

# IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

Application of:

Docket No.: 34170

Maurice Lee Smith et al.

Serial No.: 10/672,210

Group Art Unit No.: 1631

Filed: 9/26/03

SYSTEM AND METHOD FOR IDENTIFYING,

REPORTING, AND EVALUATING

PRESENCE OF SUBSTANCE

Examiner:

## **TRANSMITTAL**

Transmitted herewith are: Transmittal; Information Disclosure Statement (1 page); Information Disclosure Statement by Application PTO Form 1449 (2 pages); and return postcard.

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Express Mail No.

by

Respectfully submitted,

HOVEY WILLIAMS LLP

Dated: April 30, 2004

Thomas B. Luebbering, Reg. No. 37,874

**HOVEY WILLIAMS LLP** 

2405 Grand Boulevard, Suite 400

Kansas City, Missouri 64108

816/474-9050

ATTORNEYS FOR APPLICANT



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Examiner:

Assistant Commissioner of Patents Washington, D.C. 20231

Sir:

## INFORMATION DISCLOSURE STATEMENT

The attached references are being filed to fulfill the duty of candor and good faith toward the Patent and Trademark Office, as required by 37 C.F.R. §1.56.

Any fee which is due in connection with this Statement should be applied against Deposit Account No. 19-0522.

Respectfully submitted,

Thomas B. Luebbering, Reg. No. 37,874

HOVEY WILLIAMS LLP

2405 Grand Boulevard, Suite 400

Kansas City, Missouri 64108

(816) 474-9050

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U.S. DEPARTMENT OF COMMERCE PATENT AND TRADEMARK OFFICE ATTY. DOCKET NO. 34170

SERIAL NO. 10/672,210

INFORMATION DISCLOSURE STATEMENT BY APPLICANT

APPLICANT: Maurice Lee Smith et al.

e several sheets if necessary)

FILING DATE: 9/26/2003 GROUP: 1631

## **U.S. PATENT DOCUMENTS**

EXAM. INITIAL	DOCUMENT NUMBER				BER		DATE NAME		CLASS	SUBCLASS	FILING DATE IF APPROPRIATE	
	6	6	2	8	8 9 4 1 9/30/03		9/30/03	Knoblach et al.				
	6	6	0	8	5	5	9	8/19/03	Lemelson et al.			
	6	5	8	8	7	0	1	7/08/03	Yavnai			
	6	4	9	8	0	4	1	12/24/02	Tabacco et al.			
	6	4	9	0	5	3	0	12/03/02	Wyatt			
	6	4	4	6	0	0	4	9/03/02	Cao et al.			
	6	3	5	6	6	2	5	3/12/02	Castellani et al.			
	6	3	2	7	5	3	5	12/04/01	Evans et al.			
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# **FOREIGN PATENT DOCUMENTS**

		D	осим	ENT N	IUMBE	R		DATE	COUNTRY	CLASS	SUBCLASS	TRANSLATION	
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FORM PTO-1449 (Rev. 2-32)	U.S. DEPARTMENT OF COMMERCE PATENT AND TRADEMARK OFFICE	ATTY. DOCKET NO. 33063	SERIAL NO. 10/672,211		
	RMATION DISCLOSURE FEMENT BY APPLICANT	APPLICANT: Maurice Lee Smith et al.			
(Use s	everal sheets if necessary)	FILING DATE: 9/26/2003	GROUP: 2878		

# OTHER DOCUMENTS (Including Author, Title, Date, Pertinent Pages, Etc.)

	"Oak Ridge claims sensitivity record for Si MEMS sensor"; June 23, 2003 article in Electronic Engineering Times; Author R. Colin Johnson, page 49.

EXAMINER: Initial if citation considered, whether or not citation is in conformance with MPEP 609; Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.